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<u>L8</u>	L7 with (read\$3 or fetch\$3 or retriev\$3)	1829	<u>L8</u>
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	or mirror\$4))		
<u>L3</u>	L1 with ((stor\$4 or writ\$4 or transfer\$4) near6 (redundant or duplicat\$4 or mirror\$4))	436	<u>L3</u>
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